



DC FAN LIFE EXPERIMENT REPORT

Available for these models with lower speed and same physical structure All model may be followed by Rx or Fxx series suffixes. This test report applies to AFC80x80x20mm series as the right table	AFB0812HHD-A	AFB0812LD-A			
	AFB0812HD-A	AFB0812MD-SE24			
	AFB0812MD-A	AFB0812HD-SE28			
	AFB0812VHD-A				

Representative Test P/N :AFB0812VHD-AF00

Equipment: 1.Oven: E24-F0052

On/Off Cycles: Every 500 hours

◎ **L₁₀ Expectancy:** 70,000 hours minimum @ fan rated voltage and the temperature of 40°C

According to the equation for **Weibull distribution**, MTTF ≈ 7×L₁₀ = 490,000 hours

And we rely on a zero failure Weibull test strategy and accelerated testing technique, to determine the total test time(t) for verifying the above life estimation by the equations,

$$t = 1.036 \times \text{MTTF} \times [(B_{r;c}) \div n]^{0.91} \div A_F, \text{ and } A_F = 2^{(T_s - T_u)/10}$$

where, (B_{r;c}) is Poisson distribution factor with the failure number of r equal to 0 and

the decimal confidence level of c equal to 0.90(90%).

Stress/Elevated Temperature Ts (°C) (Actual Test Temperature)	Unstress Temperature Tu (°C)	Acceleration Factor A _F	Quantity of Test Devices n (pcs)	Poisson Distribution Factor B _{r;c}	Required test time with zero failure t (hours)	Actual test time with zero failure t (hours)	Verified MTTF 40 °C (hours)	Verified L ₁₀ 40 °C (hours)
60	40	4.00	56	2.303	6,956	6,956.0	490,031	70,004

Test Progress:

Date for Test Beginning	Date for Test Termination (at least)	Current Test Status			Current Total Test Time (hours)
2004/5/31 7:00 PM	2005/5/5 4:03 PM	<input type="checkbox"/> In process	<input type="checkbox"/> In process (exceed requested)	<input checked="" type="checkbox"/> Termination	6956.0

Herewith , we could assume as right on the basis of above test result. Besides, if the actual test time exceed the required, it comes out that those fans' L₁₀ expectancy and MTTF are greater than the warrant. (MTTF : means Mean Time To Failures, it should be used in a non-repairable system setting. Now we show the MTTF in our life report, that's because we will not repair the failed fans during life experiment. MTBF: means Mean Time Between failures, it should be used in a repairable system setting.

Fan permission criteria for the measurement after test :

1. For current, the limit is less than spec.(max.).

For speed, the allowable decrease is less than 15%.

noise, the limit is less than spec.(max.). + 3 dB

Temperature for MTTF Estimation (°C)	Acceleration Factor A _F	Estimated MTTF (hours)	Estimated L ₁₀ (hours)
25	11.31	1,386,017	198,002
30	8.00	980,062	140,009
40	4.00	490,031	70,004
50	2.00	245,015	35,002
60	1.00	122,508	17,501

Test Result

- Accept
- Reject

QE File No.	Time-out for function test or others (hours)	Issued Date	Reported By	Approved By
DG04FNL154	1177.50	2005/5/5 4:30 PM	Guie.Lin	Gx.Xu

Note: The test sample equivalent to STD , Part number: AFB0812VHD-AF00



DC FAN FUNCTION TEST RECORD FOR LIFE EXPERIMENT

Available for these models with lower speed and same physical structure. All model may be followed by Rxx or Fxx series suffixes. This test report applies to AFC80x80x20mm series as the right table	AFB0812HHD-A	AFB0812LD-A			
	AFB0812HD-A	AFB0812MD-SE24			
	AFB0812MD-A	AFB0812HD-SE28			
	AFB0812VHD-A				

Required Test Time (hrs)	Date for Test Beginning	Date for Test Termination	Sample Size (pcs):	Failure (pcs):	Current Total Test Time (hrs)
6,956	2004/5/31 7:00 PM	2005/5/5 4:03 PM	56	0	6956.0
Representative Test P/N :AFB0812VHD-AF00			Current Test Status		<input type="checkbox"/> In process (exceed requested) <input checked="" type="checkbox"/> Termination
Equipment: 1.Oven: E24-F0052			On/Off Cycles: Every 500 hours		

Test Data Between Initial Test and Final Test

Sample No.	Initial Test	Final Test	Deviation (%)	Initial Test	Final Test	Deviation (%)	Initial Test	Final Test	Deviation (%)
	Current Spec. (A)	Current Spec. (A)		Speed Spec. (RPM)	Speed Spec. (RPM)		Noise Spec. (dB A)	Noise Spec. (dB A)	
36	0.28	0.28	0.0	4895	4876	-0.4	45.6	46.1	1.1
37	0.28	0.28	0.0	4860	4921	1.3	45.4	45.9	1.1
38	0.29	0.29	0.0	4846	4875	0.6	44.8	46.4	3.6
39	0.27	0.27	0.0	4850	4783	-1.4	45.2	46.7	3.3
40	0.30	0.30	0.0	4892	4830	-1.3	45.9	46.5	1.3
41	0.29	0.30	3.4	4911	4878	-0.7	45.3	46.4	2.4
42	0.29	0.29	0.0	4880	4881	0.0	44.8	46.2	3.1
43	0.28	0.28	0.0	4910	4876	-0.7	45.1	46.4	2.9
44	0.29	0.29	0.0	4886	4895	0.2	45.7	46.7	2.2
45	0.29	0.29	0.0	4805	4835	0.6	44.8	45.2	0.9
46	0.28	0.28	0.0	4930	4897	-0.7	45.2	45.4	0.4
47	0.29	0.29	0.0	4926	4912	-0.3	45.6	45.9	0.7
48	0.27	0.27	0.0	4870	4806	-1.3	45.3	46.3	2.2
49	0.28	0.27	-3.6	4812	4902	1.9	45.7	46.7	2.2
50	0.28	0.29	3.6	4889	4854	-0.7	44.8	45.3	1.1
51	0.28	0.28	0.0	4820	4828	0.2	45.1	45.9	1.8
52	0.28	0.28	0.0	4818	4828	0.2	45.3	45.7	0.9
53	0.28	0.29	3.6	4889	4811	-1.6	45.7	46.2	1.1
54	0.28	0.29	3.6	4869	4878	0.2	45.9	46.7	1.7
55	0.29	0.28	-3.4	4853	4866	0.3	45.3	46.6	2.9
56	0.29	0.29	0.0	4876	4845	-0.6	44.9	46.3	3.1
X-Bar	0.282	0.283	-	4862.1	4853.2	-	45.18	46.17	-
σ	0.009	0.010	-	36.238	40.224	-	0.407	0.453	-

QE File No.	Time-out for function test or others (hrs)	Issued Date	Reported By	Approved By
DG04FNL154	1177.50	2005/5/5 4:30 PM	Guie.Lin	Gx.Xu